

Search Notes

Application/Control No.

10/623,556

Examiner

Nhan T. Tran

Applicant(s)/Patent under
Reexamination

SHIRAISHI, KENJI

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB text search - see search history printout		10/29/2007	NT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPAT, JPO, EPO, DERWENT, IBM_TDB)	10/4/2007	NT
Text search classes 348, 358, 386 and 382 - see search history printout	10/28/2007	NT
Text search all classes - see search history printout	10/28/2007	NT
Inventorship search - see search history printout	10/29/2007	NT